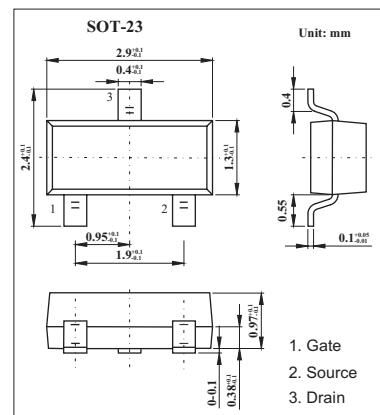
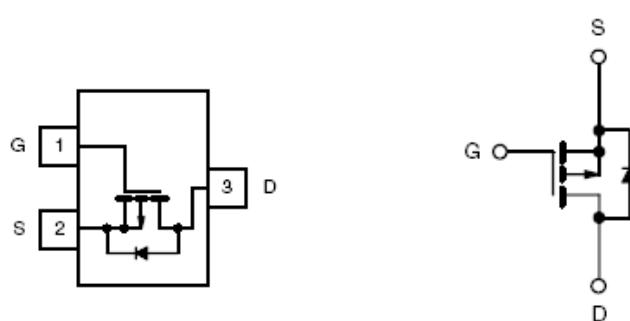


P-Channel 12-V (D-S) MOSFET

KI2337DS

■ Features

- TrenchFET Power MOSFET



■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	5 sec	Unit
Drain-Source Voltage	V _{DS}	-80	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current(T _J =150°C) T _c =25°C T _c =70°C	I _D	-2.2 -1.75	A
Continuous Drain Current(T _J =150°C) *1,2 T _A =25°C T _A =70°C	I _D	-1.2 -0.96	A
Pulsed Drain Current	I _{DM}	-7	A
Continuous Source Drain Diode Current T _c =25°C	I _S	-2.1	
Continuous Source Drain Diode Current *1,2 T _A =25°C		-0.63	
Avalanche Current L = 0.1 mH	I _{AS}	11	
Single-Pulse Avalanche Energy L = 0.1 mH	E _{AS}	6.0	mJ
Power Dissipation T _c =25°C T _c =70°C	P _D	2.5 1.6	W
Power Dissipation *1,2 T _A =25°C T _A =70°C	P _D	0.76 0.48	W
Junction Temperature	T _j	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature)*3		260	°C

*1Surface mounted on 1" x 1" FR4 Board.

*2 t = 10 sec

*3 Maximum under steady state conditions is 166 °C/W.

KI2337DS■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu \text{A}$	-80			V
VDS Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = -250 \mu \text{A}$		-35.8		$\text{mV}/^\circ\text{C}$
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$	$I_D = -250 \mu \text{A}$		5.45		
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250 \mu \text{A}$	-2		-4	V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}$		-1		μA
		$V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$		-10		
On-State Drain Current	$I_{D(\text{on})}$	$V_{DS} \geq -5 \text{ V}, V_{GS} = -10 \text{ V}$	-7			A
Drain-Source On-State Resistance *	$r_{DS(\text{on})}$	$V_{GS} = -10 \text{ V}, I_D = -1.2 \text{ A}$		0.216	0.270	Ω
		$V_{GS} = -6 \text{ V}, I_D = -1.1 \text{ A}$		0.242	0.303	
Forward Transconductance *	g_{fs}	$V_{DS} = -15 \text{ V}, I_D = -1.2 \text{ A}$		4.3		S
Input Capacitance	C_{iss}			500		pF
Output Capacitance	C_{oss}	$V_{DS} = -40 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		40		
Reverse Transfer Capacitance	C_{rss}			25		
Total Gate Charge	Q_g	$V_{DS} = -40 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -1.2 \text{ A}$		11	17.0	
Total Gate Charge	Q_g			7	11.0	nC
Gate-Source Charge	Q_{gs}	$V_{DS} = -40 \text{ V}, V_{GS} = -6 \text{ V}, I_D = -1.2 \text{ A}$		2.1		
Gate-Drain Charge	Q_{gd}			3.2		
Gate Resistance	R_g	$f = 1 \text{ MHz}$		4.8		Ω
Turn-On Delay Time	$t_{d(on)}$			10	15	ns
Rise Time	t_r			15	23	
Turn-Off Delay Time	$t_{d(off)}$	$V_{DD} = -40 \text{ V}, R_L = 42 \Omega, I_D = -0.96 \text{ A}, V_{GEN} = -10 \text{ V}, R_G = 1 \Omega$		20	30	
Fall Time	t_f			15	23	
Turn-On Delay Time	$t_{d(on)}$			15	23	ns
Rise Time	t_r			18	27	
Turn-Off Delay Time	$t_{d(off)}$	$I_F = 0.63 \text{ A}, dI/dt = 100 \text{ A}/\mu \text{s}, T_J = 25^\circ\text{C}$		20	30	
Fall Time	t_f			12	18	
Continuous Source-Drain Diode Current	I_S	$T_c = 25^\circ\text{C}$			-2.1	A
Pulse Diode Forward Current*	I_{SM}				-7	
Body Diode Voltage	V_{SD}	$I_S = 0.63 \text{ A}$		-0.8	-1.2	V
Body Diode Reverse Recovery Time	t_{rr}			30	45	ns
Body Diode Reverse Recovery Charge	Q_{rr}			45	70	nC
Reverse Recovery Fall Time	t_a			25		ns
Reverse Recovery Rise Time	t_b			5		

* Pulse test: $PW \leq 300 \mu \text{s}$ duty cycle $\leq 2\%$.

■ Marking

Marking	E7
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